Notice of References Cited Application/Control No. 10/593,137 Applicant(s)/Patent Under Reexamination OKUBO ET AL. Examiner Brieann R. Fink 1796 Applicant(s)/Patent Under Reexamination OKUBO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	JP 04159315 A	06-1992	Japan	UCHIDA et al.	
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NON-PATENT DOCUMENTS

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U	Derwent Abstract for JP 04159315. Derwent Acc. No. 1992-231959					
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